Search Notes

	Application/Control No.	Applicant(s)/Pate Reexamination	ent under
	10/661,248	VARNERIN ET	AL.
ſ	Examiner	Art Unit	
	Eric B. Chen	1765	

SEARCHED					
Class	Subclass	Date	Examiner		
438	401,462	4/28/2005	EC		
438	700	4/28/2005	EC		
438	706,710	4/28/2005	EC		
438	719	4/28/2005	EC		
438	723,724	4/28/2005	EC		
438	745	4/28/2005	EC		
438	756,757	4/28/2005	EC		
438	690-692	4/28/2005	EC		
216	18,39	4/28/2005	EC		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Performed inventor search for double patenting	4/26/2005	EC		
EAST search	4/28/2005	EC		